



# EMC TEST REPORT

**Report No.:** SET2014-00157

**Product Name:** GSM/WCDMA MOBILE PHONE

**FCC ID:** CLNSS10501

**Model No. :** M4 SS1050

**Applicant:** MFOURTEL MEXICO S.A. DE C.V.

**Address:** Homero No. 136 – 101 Col. Chapultepec Morales, C.P. 11570,  
Delegación Miguel Hidalgo

**Received Date:** 2013-12-20

**Tested Date:** 2013-12-20—2013-12-28

**Issued by:** CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

**Lab Location:** Electronic Testing Building, Shahe Road, Xili, Nanshan District,  
Shenzhen, 518055, P. R. China

**Tel:** 86 755 26627338    **Fax:** 86 755 26627238

This test report consists of **23** pages in total. It may be duplicated completely for legal use with the approval of the applicant. It should not be reproduced except in full, without the written approval of our laboratory. The client should not use it to claim product endorsement by CCIC-SET. The test results in the report only apply to the tested sample. The test report shall be invalid without all the signatures of testing engineers, reviewer and approver. Any objections must be raised to CCIC-SET within 20 days since the date when the report is received. It will not be taken into consideration beyond this limit.



### Test Report

**Product Name** ..... : GSM/WCDMA MOBILE PHONE

**Model No.** ..... : M4 SS1050

**Applicant** ..... : MFOURTEL MEXICO S.A. DE C.V.

**Applicant Address** ..... : Homero No. 136 – 101 Col. Chapultepec Morales, C.P.  
11570, Delegación Miguel Hidalgo

**Manufacturer** ..... : CK Telecom Limited

**Manufacturer Address** ..... : Technology Road. High-Tech Development Zone. Heyuan,  
Guangdong, P.R. China.

**Test Standards** ..... : 47 CFR Part 15 Subpart B: Radio Frequency Devices

**Test Result** ..... : PASS

**Tested by** ..... : Xiaolong Zhang 2014.1.6  
Xiaolong Zhang, Test Engineer

**Reviewed by** ..... : Shuangwen Zhang 2014.1.6  
Shuangwen Zhang, Senior Engineer

**Approved by** ..... : Wu Lian 2014.1.6  
Wu Lian, Manager



### TABLE OF CONTENTS

- 1. GENERAL INFORMATION .....4**
- 1.1 EUT Description .....4**
- 1.2 Test Standards and Results .....5**
- 1.3 Facilities and Accreditations .....6**
  - 1.3.1 Facilities .....6
  - 1.3.2 Test Environment Conditions .....6
  - 1.3.3 Measurement Uncertainty .....6
- 2. TEST CONDITIONS SETTING .....7**
- 2.1 Test Mode .....7**
- 2.2 Test Setup and Equipments List .....8**
  - 2.2.1 Conducted Emission .....8
  - 2.2.2 Radiated Emission .....8
- 3. 47 CFR PART 15B REQUIREMENTS .....12**
- 3.1 Conducted Emission .....12**
  - 3.1.1 Requirement .....12
  - 3.1.2 Test Description .....12
  - 3.1.3 Test Result .....12
- 3.2 Radiated Emission .....15**
  - 3.2.1 Requirement .....15
  - 3.2.2 Test Description .....16
  - 3.2.3 Test Result .....16
- 4. PHOTOGRAPHS OF THE EUT .....21**
- 5. PHOTOGRAPHS OF THE TEST SET-UP .....22**

Change History		
Issue	Date	Reason for change
1.0	Jan.6,2014	First edition



# 1. GENERAL INFORMATION

## 1.1 EUT Description

EUT Type ..... : M4 SS1050  
Serial No. .... : (n.a, marked #1 by test site)v  
FCC ID ..... : CLNSS10501  
Hardware Version..... : SLSPLUS-V1.0  
Software Version ..... : M4\_SS1050\_S07\_Ver200  
Power Supply ..... : Battery  
                                  Brand Name: M4  
                                  Model No.: M1500A  
                                  Serial No.: (n.a. marked #1 by test site)  
                                  Capacitance: 1500mAh  
                                  Rated Voltage: 3.7V  
                                  Charge Limit: 4.2V  
Ancillary Equipment 1 ..... : AC Adapter (Charger for Battery)  
                                  Brand Name: M4  
                                  Model No.: HKC0055010-2R  
                                  Serial No.: (n.a. marked #1 by test site)  
                                  Rated Input: 100-240V, 0.2A, 50/60Hz  
                                  Rated Output: 5V=500mA  
Ancillary Equipment 2..... : PC  
                                  Brand Name:ThinkPad  
                                  Model Name:E420  
                                  Serial No.:1141AH6

*Note 1:* The EUT is a GSM/WCDMA MOBILE PHONE, it supports the following operating mode and frequency band: GSM850/PCS1900/WCDMA2100 and 802.11b, 802.11g, 802.11n/20M, 802.11n/40M and Bluetooth 4.0

*Note 2:* The EUT is equipped with a T-Flash card slot; equipped with a USB port which can be connected to the ancillary equipments supplied by the manufacturer e.g. the AC Adapter and the USB Cable.

*Note 3:* For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.



## 1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B 2012	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE: The EUT has been tested according to 47 CFR Part 15 Subpart B, Class B. The test procedure is according to ANSI C63.4:2009 and CISPR 22:2008. The test results are as following:



### 1.3 Facilities and Accreditations

#### 1.3.1 Facilities

**CNAS-Lab Code: L1659**

CCIC-SET Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 12.8\*6.8\*6.4 (m) fully anechoic chamber was used for the radiated spurious emissions test.

**FCC-Registration No.: 406086**

CCIC-SET Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, Renewal date Nov. 19, 2011, valid time is until Nov. 18, 2014.

#### 1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature ( °C):	15°C - 35°C
Relative Humidity (%):	30% -60%
Atmospheric Pressure (kPa):	86KPa-106KPa

#### 1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)



## 2. TEST CONDITIONS SETTING

### 2.1 Test Mode

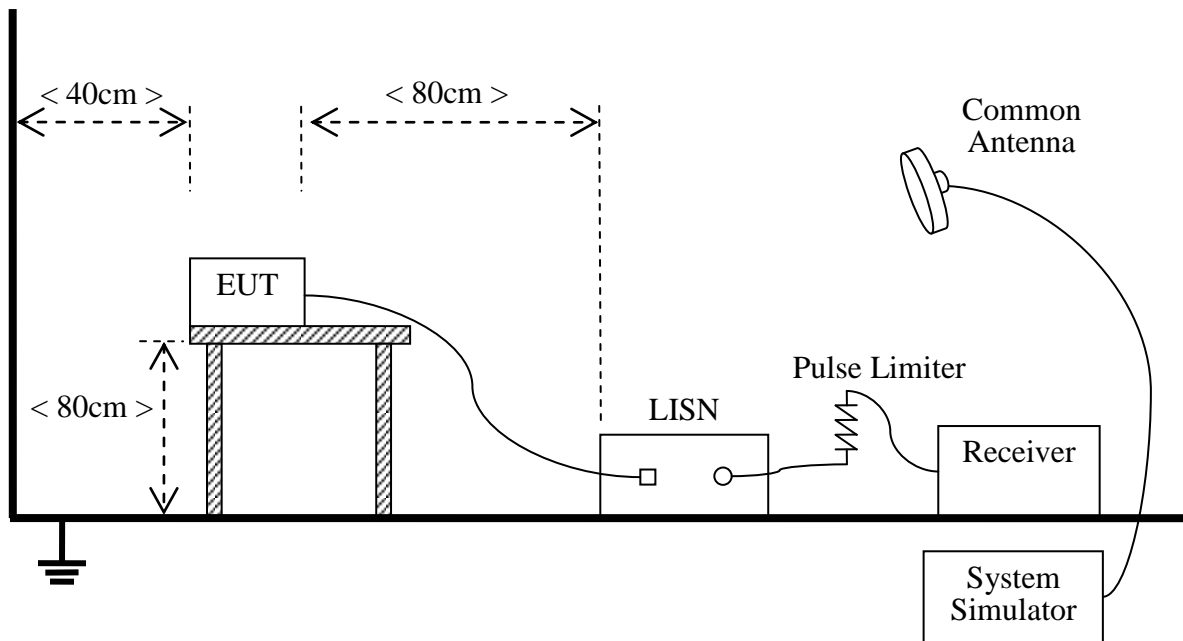
(1) The test mode (USB)

The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC. In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), the data is transmitting between the PC and the TransFlash Card of the EUT.

## 2.2 Test Setup and Equipments List

### 2.2.1 Conducted Emission

#### A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides  $50\Omega/50\mu\text{H}$  of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

#### B. Equipments List:

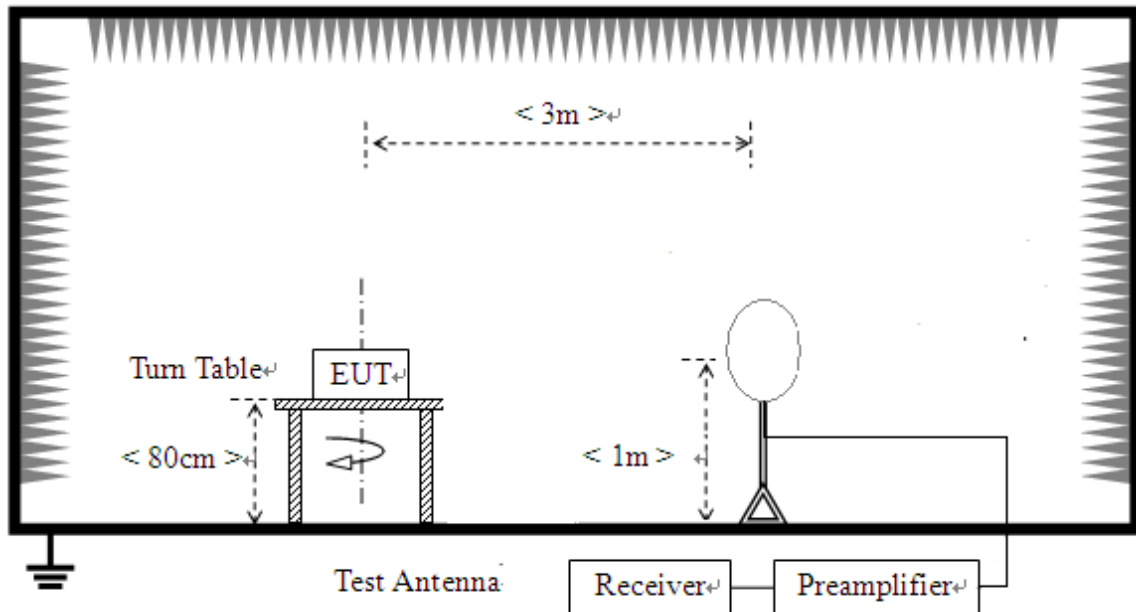
Description	Manufacturer	Model	Serial No.	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESCS30	A0304260	2014.06.10
LISN	ROHDE&SCHWARZ	ESH2-Z5	A0304221	2014.06.10

### 2.2.2 Radiated Emission

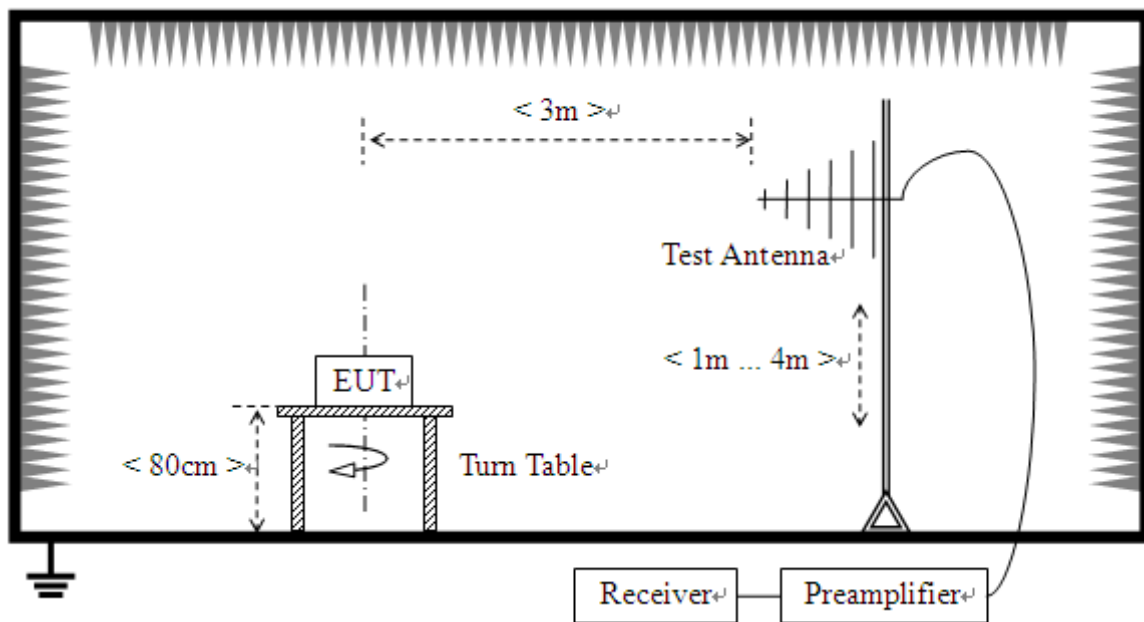
#### A. Test Setup:

- 1) For radiated emissions from 9kHz to 30MHz

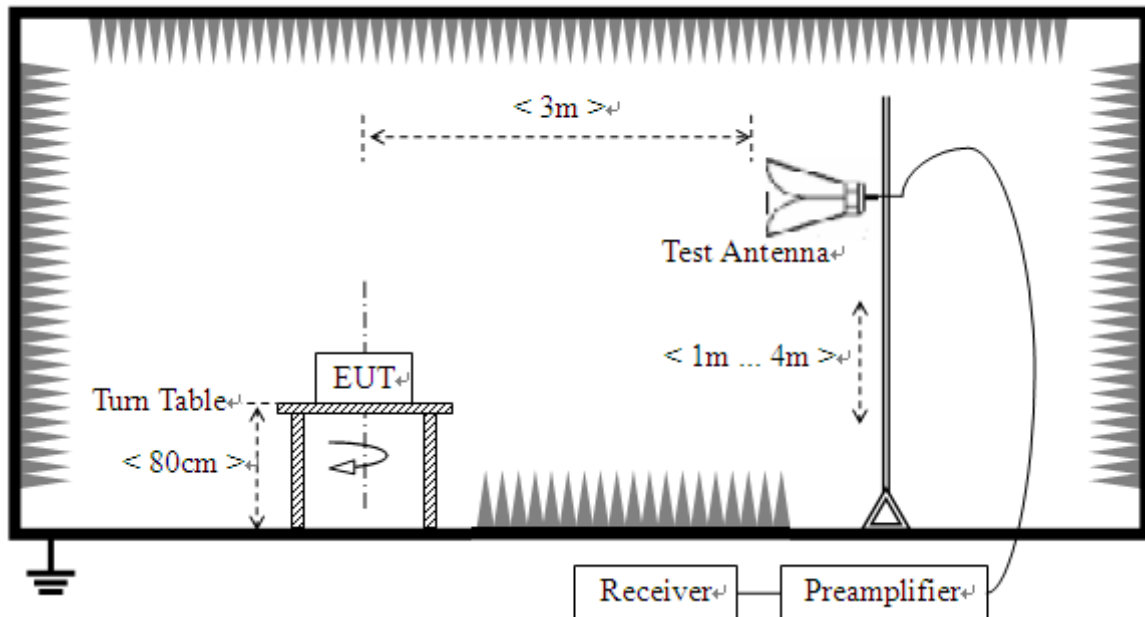




2) For radiated emissions from 30MHz to 1GHz



3) For radiated emissions above 1GHz



## B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range of 9KHz to 30MHz, magnetic field is measured with Loop Test Antenna.

The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.

- 2) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

## C. Equipments List:



Description	Manufacturer	Model	Serial No.	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2014.06.10
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2014.06.10
Semi-Anechoic Chamber	Albatross	9m*6m*6m	A0412372	2015.01.04
Test Antenna - Bi-Log	HP	CBL6111A	A9704202	2014.06.10
Test Antenna - Horn	ROHDE&SCHWARZ	HF906	A0304225	2014.06.10
System Simulator	ROHDE&SCHWARZ	CMU200	A0304212	2014.06.10
Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4 m	A0304210	2014.03.09
Ampilier 1G~18GHz	ROHDE&SCHWARZ	MITEQ AFS42-0010 1800	A0509366	2014.06.10
amplifier 20M~3GHz	Compliance Direction System	PAP-0203H	A0509377	2014.06.10



### 3. 47 CFR PART 15B REQUIREMENTS

#### 3.1 Conducted Emission

##### 3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50  $\mu$ H/50 $\Omega$  line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB $\mu$ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- The limit subjects to the Class B digital device.
- The lower limit shall apply at the band edges.
- The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

##### 3.1.2 Test Description

See section 2.2.1 of this report.

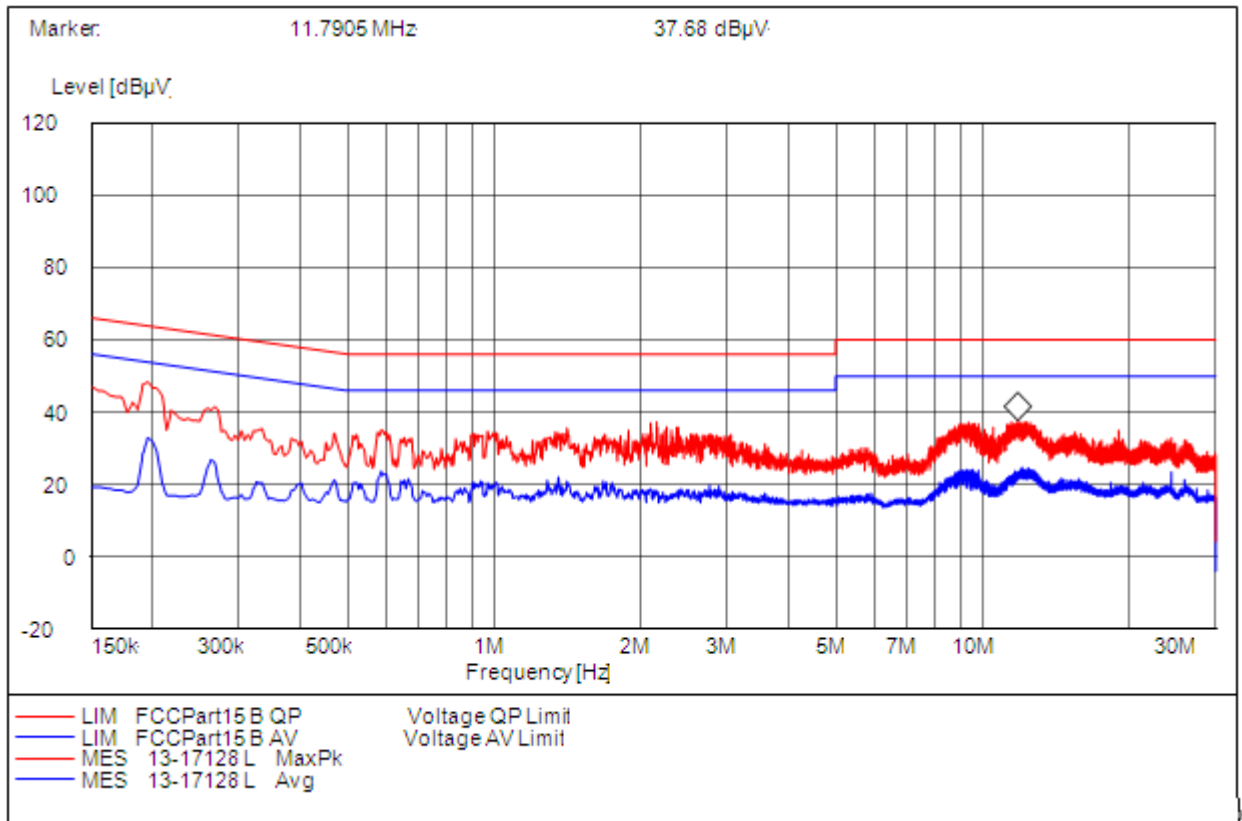
##### 3.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

##### 3.1.3.1 Test Mode

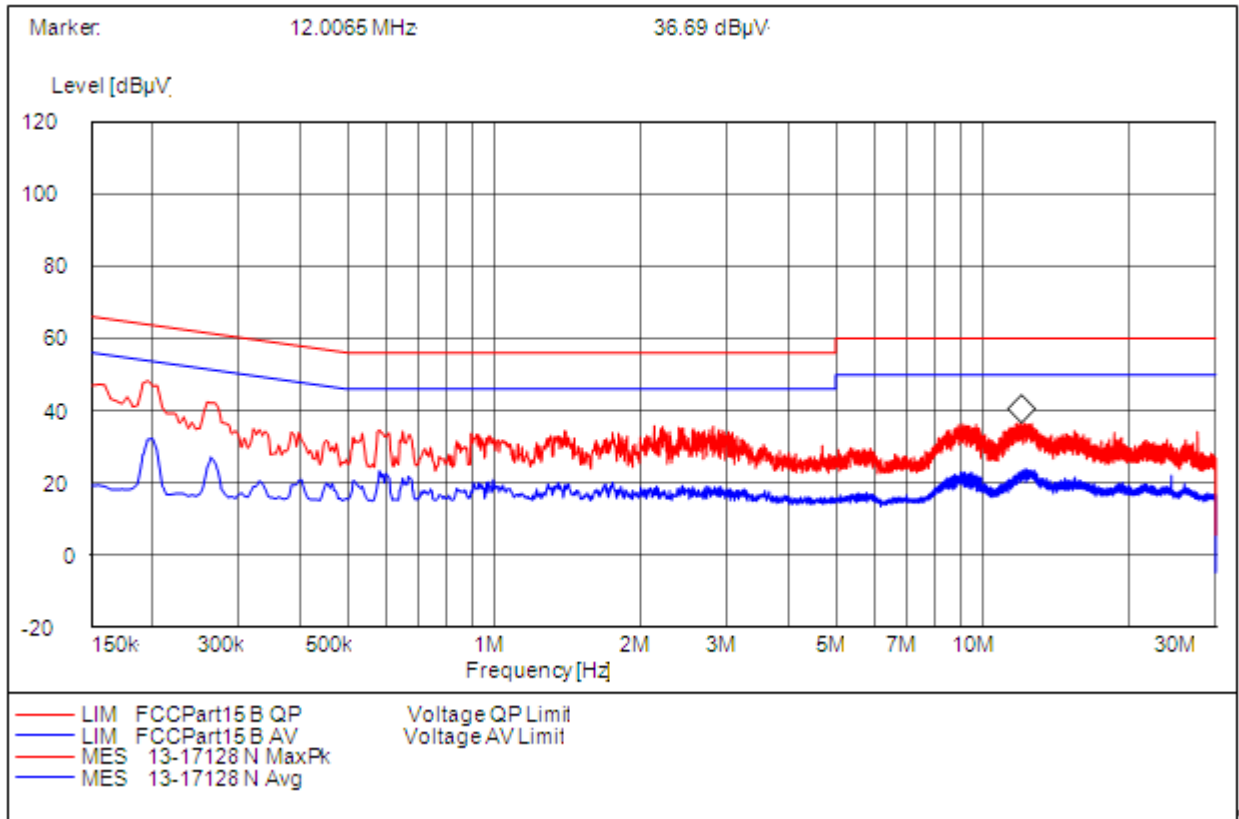


**A. Test Plot and Suspicious Points:**



Conducted Disturbance at Mains Terminals							
L Test Data							
QP				AV			
Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)
0.1950	63.80	45.34	8.46	0.1950	53.80	34.20	19.60
0.2670	61.20	39.51	21.69	0.2670	51.20	27.40	23.80
11.7905	60	34.68	25.32	11.7905	50	21.10	28.90
L Test Curve							

(Plot A: L Phase)



Conducted Disturbance at Mains Terminals							
N Test Data							
QP				AV			
Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measurement Value (dBµV)	Margin (dB)
0.1950	63.80	46.29	17.51	0.1950	53.80	32.90	20.90
0.2580	61.50	39.40	12.10	0.2580	51.50	24.80	26.70
12.0065	60	33.69	26.31	12.0065	50	30.70	19.30
N Test Curve							

(Plot B: N Phase)

**Test Result: PASS**

## 3.2 Radiated Emission

### 3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength		Field Strength Limitation at 3m Measurement Dist	
	$\mu\text{V/m}$	Dist	( $\text{uV/m}$ )	( $\text{dBuV/m}$ )
0.009 - 0.490	$2400/F(\text{KHz})$	300m	$10000 * 2400/F(\text{KHz})$	$20\log 2400/F(\text{KHz}) + 80$
0.490 - 1.705	$2400/F(\text{KHz})$	30m	$100 * 2400/F(\text{KHz})$	$20\log 2400/F(\text{KHz}) + 40$
1.705 - 30.00	30	30m	$100 * 30$	$20\log 30 + 40$
30.0 - 88.0	100	3m	100	$20\log 100$
88.0 - 216.0	150	3m	150	$20\log 150$
216.0 - 960.0	200	3m	200	$20\log 200$
Above 960.0	500	3m	500	$20\log 500$

- a) As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- b) Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- c) For below 1G :QP detector RBW 120KHz ,VBW 300KHz.
- d) For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;PK detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in  $\text{dBuV/m}$  is calculated by  $20\log \text{Emission Level}(\text{uV/m})$ .
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of  $Ld1 = Ld2 * (d2/d1)^2$ .

Example:

F.S Limit at 30m distance is  $30\text{uV/m}$ , then F.S Limitation at 3m distance is adjusted as

$$Ld1 = L1 = 30\text{uV/m} * (10)^2 = 100 * 30\text{uV/m}.$$

### 3.2.2 Test Description

See section 2.2.2 of this report.

### 3.2.3 Test Result

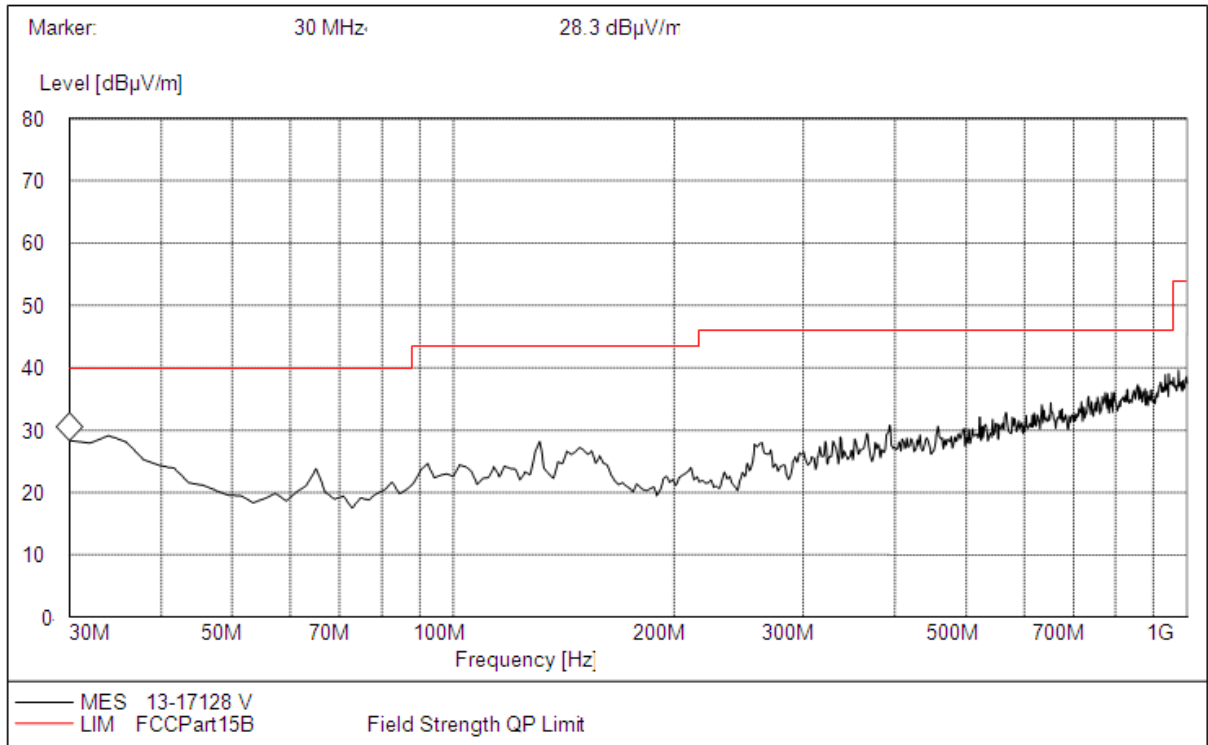
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

#### A. Test Plots and Suspicious Points:

NOTE: The emissions are too small to be measured and are at least 6 dB below the limit, So all the data of marked are pass.

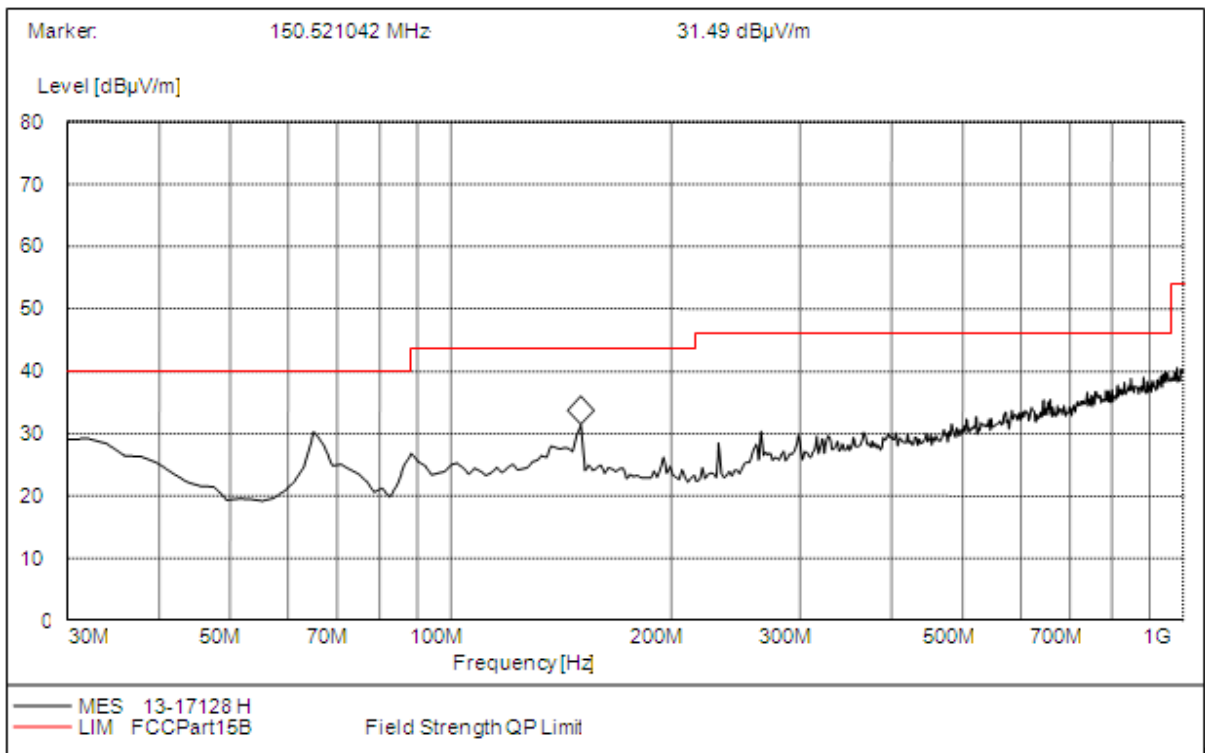






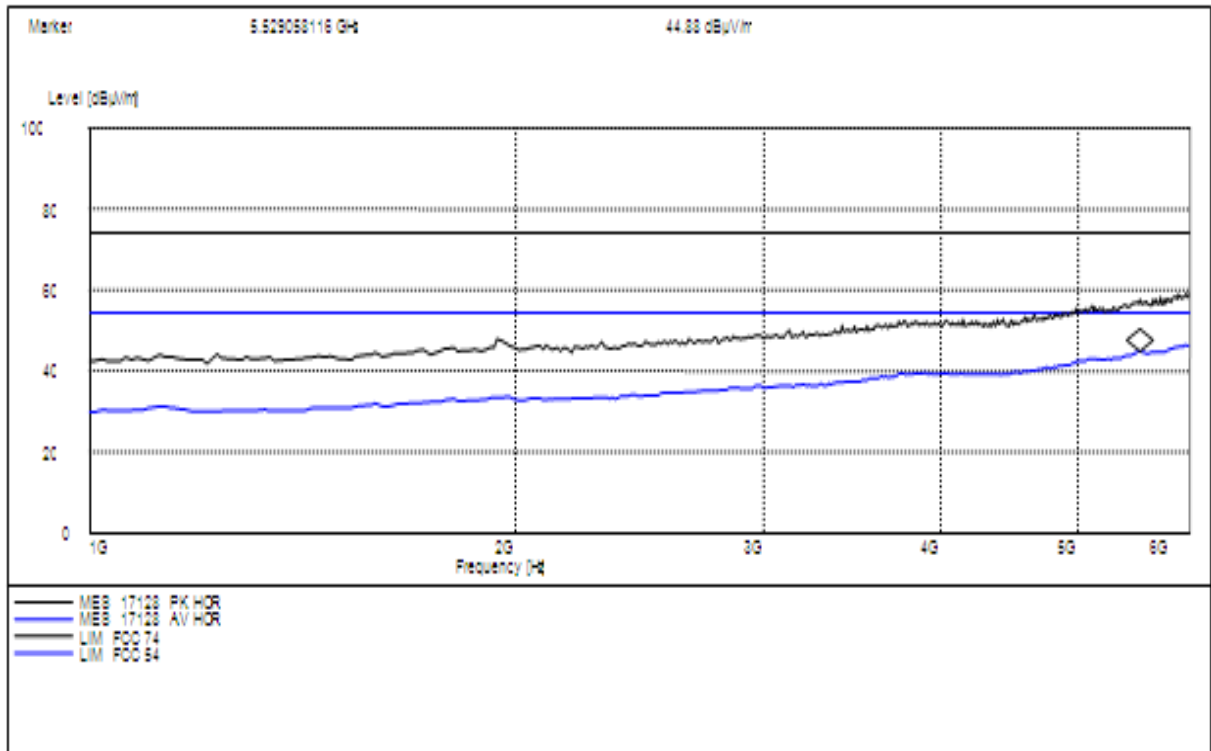
(Plot A: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB $\mu$ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB $\mu$ V/m)	Margin (dB)	Antenna	Verdict
30.000000	28.30	120.000	100.0	40.00	11.70	Vertical	Pass
143.246340	28.25	120.000	100.0	43.50	15.25	Vertical	Pass
561.141524	32.76	120.000	100.0	46.00	13.24	Vertical	Pass



(Plot B: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dB $\mu$ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB $\mu$ V/m)	Margin (dB)	Antenna	Verdict
65.102204	30.12	120.000	100.0	40.00	9.88	Horizontal	Pass
150.521042	31.49	120.000	100.0	43.50	12.02	Horizontal	Pass
569.293425	33.01	120.000	100.0	46.00	12.99	Horizontal	Pass



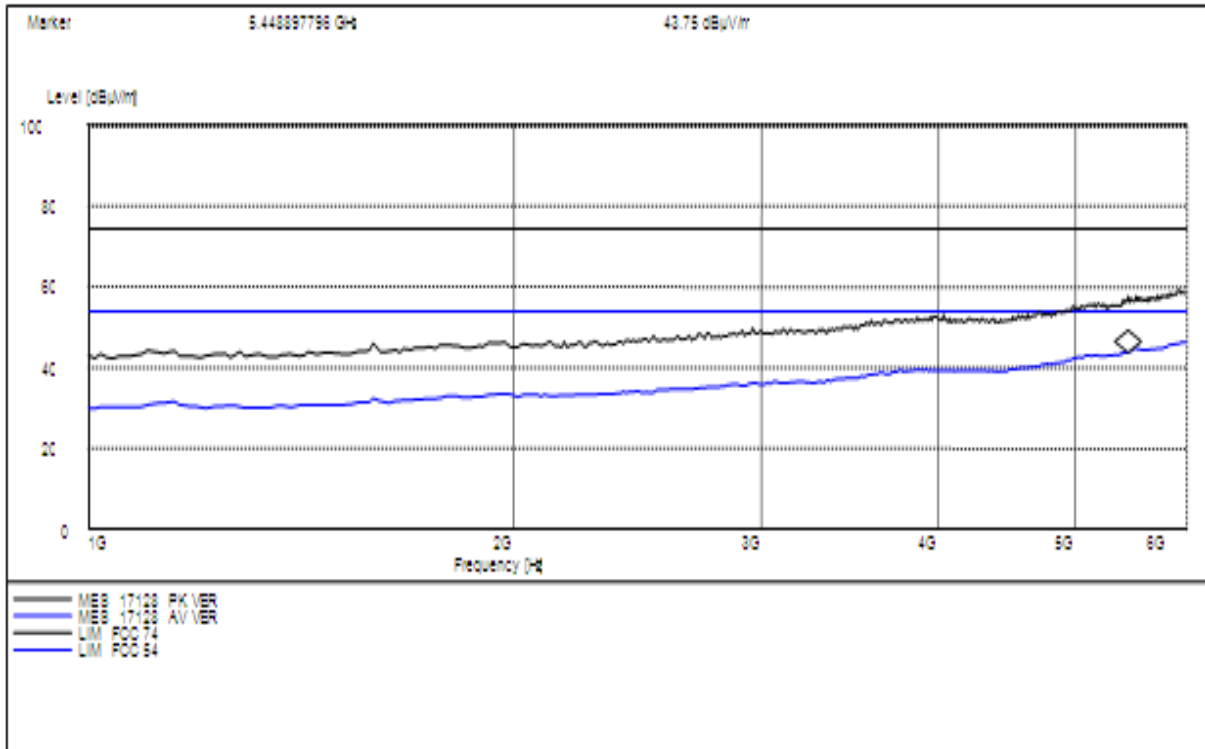
(Plot C: Test Antenna Horizontal 1G – 6G)

Frequency (MHz)	AV (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
1150.30060	31.70	1000.000	100.0	54.00	23.30	Horizontal	Pass
1921.84368	33.30	1000.000	150.0	54.00	20.70	Horizontal	Pass
2953.90781	36.20	1000.000	150.0	54.00	17.80	Horizontal	Pass
4717.43487	40.30	1000.000	100.0	54.00	13.70	Horizontal	Pass
5448.97796	43.80	1000.000	150.0	54.00	10.20	Horizontal	Pass
5970.94268	44.57	1000.000	100.0	54.00	9.43	Horizontal	Pass

Frequency (MHz)	PK (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
1120.24040	44.40	1000.000	150.0	74.00	29.60	Vertical	Pass
1941.88374	47.85	1000.000	150.0	74.00	26.15	Vertical	Pass
2943.88776	48.36	1000.000	150.0	74.00	25.64	Vertical	Pass



3735.47094	52.14	1000.000	180.0	74.00	21.86	Vertical	Pass
5529.05811	57.64	1000.000	150.0	74.00	16.36	Vertical	Pass
5921.82347	59.01	1000.000	100.0	74.00	14.99	Vertical	Pass



(Plot D: Test Antenna Vertical 1G – 6G)

Frequency (MHz)	AV (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
1120.24040	31.60	1000.000	150.0	54.00	22.40	Vertical	Pass
1941.88374	33.30	1000.000	150.0	54.00	20.70	Vertical	Pass
2943.88776	35.70	1000.000	150.0	54.00	18.30	Vertical	Pass
3735.47094	39.30	1000.000	180.0	54.00	14.70	Vertical	Pass
5529.05811	44.90	1000.000	150.0	54.00	9.10	Vertical	Pass
5921.82347	46.10	1000.000	100.0	54.00	7.90	Vertical	Pass



Frequency (MHz)	PK (dB $\mu$ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB $\mu$ V/m)	Margin (dB)	Antenna	Verdict
1150.30060	44.21	1000.000	100.0	74.00	29.79	Horizontal	Pass
1921.84368	46.25	1000.000	150.0	74.00	27.75	Horizontal	Pass
2953.90781	49.85	1000.000	150.0	74.00	24.15	Horizontal	Pass
4717.43487	53.88	1000.000	100.0	74.00	20.12	Horizontal	Pass
5448.97796	57.79	1000.000	150.0	74.00	16.21	Horizontal	Pass
5970.94268	59.40	1000.000	100.0	74.00	14.60	Horizontal	Pass

**Test Result: PASS**

#### 4. PHOTOGRAPHS OF THE EUT





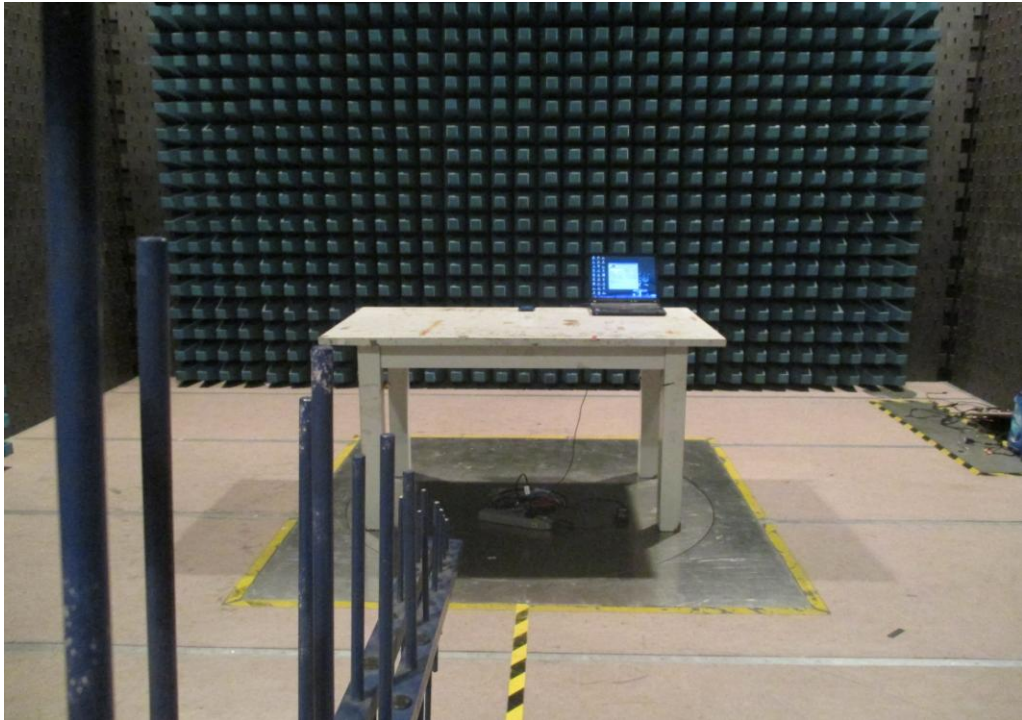
## 5. PHOTOGRAPHS OF THE TEST SET-UP



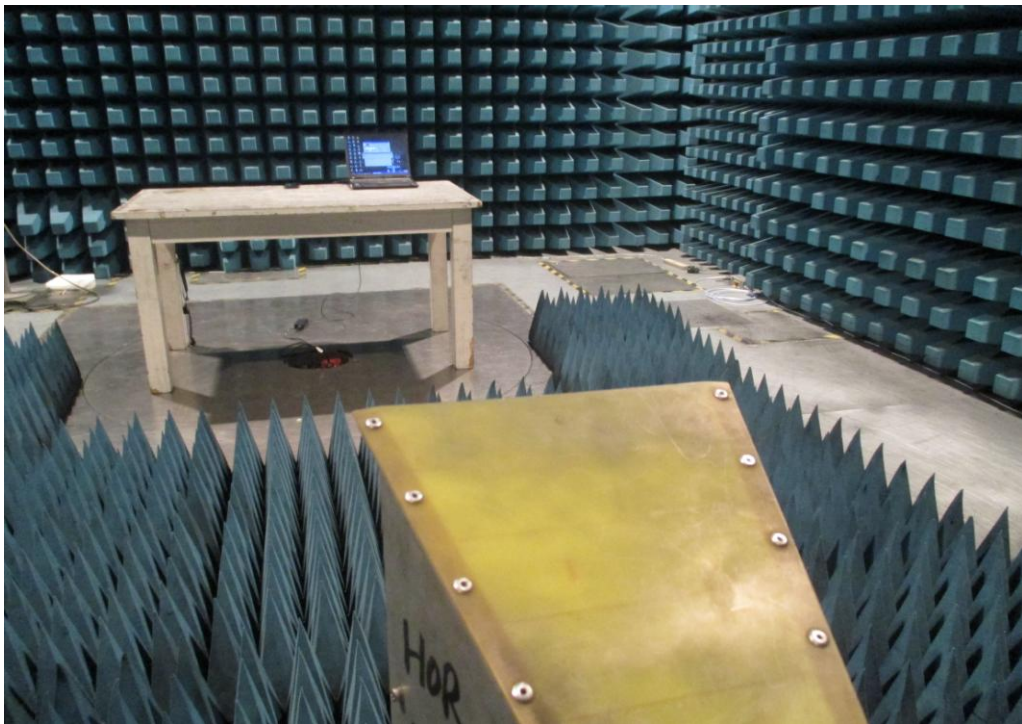
Conducted Emission



Radiated Emission of 9k-30M



Radiated Emission of 30M-1G



Radiated Emission of 1-6G

\*\* END OF REPORT \*\*